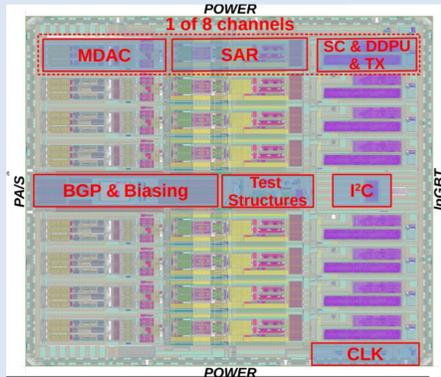




Production Testing of the COLUTA ASIC for the ATLAS HL-LHC Liquid Argon Calorimeter Readout

COLUTA ADC

- **COLUTA**—collaboration of Nevis labs at Columbia University and UT Austin.
- Design requirements:
 - Sampling frequency: 40 MSPS
 - Dynamic range: 15 bits
 - Precision: ≥ 11 ENOB
 - Power: <100 mW per channel
 - Radiation hardness requirements [3]:



ASIC	TID [kGy]	NIEL [n_{eq}/cm^2]	SEE [$h_{>20}$ MeV/ cm^2]
ADC	1.4	4.1×10^{13}	1.0×10^{13}

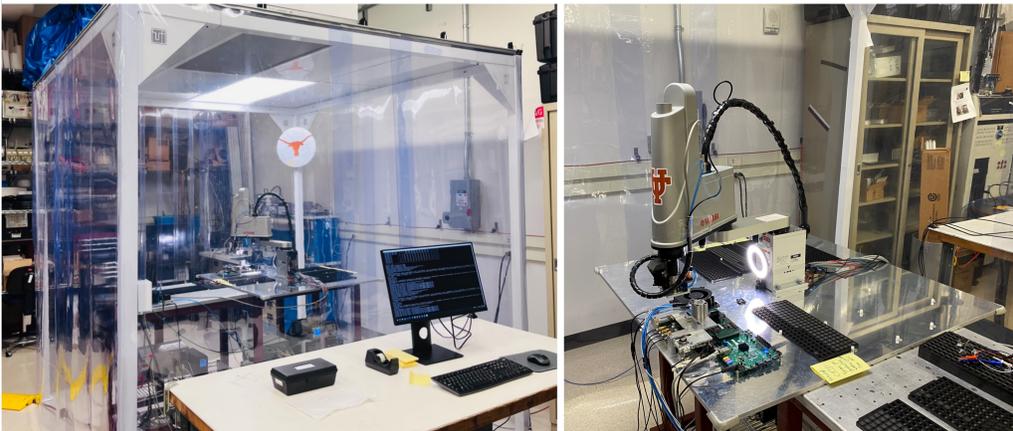
- Eight identical channels consists of a multiplying DAC (MDAC) followed by a two-stage pipeline SAR.
- Digital Data Processing Unit (DDPU) combines SAR and MDAC bits and serializes the digital data at 640 Mbps per channel.

Production Testing

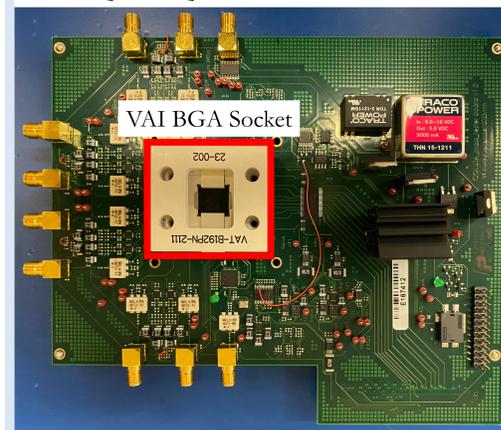
- COLUTA ADC packaged in a 196-ball BGA package.
- Perform quality assurance and quality control (QA/QC) for 80,000 COLUTA ADC chips to be installed on 1524 on-detector front-end boards.
- Built an automated, robotic test setup to perform QA/QC testing.
- Custom test board with identical analog inputs to measure uniformly the ADC performance.
- Chip performance evaluated using a series of analog and digital measurements.
- Chip performance and QA/QC results archived in an online, CERN database.
- Each chip takes 5 minutes to test.
- Tested 1000 pre-production chips with first version of the QA/QC testboard.
- Observe $>90\%$ yield with optimal test conditions.
- Shipped 500 tested chips to be installed on prototype front-end boards.
- Designing second version of the QA/QC testboard based on results from first round of QA/QC testing.
- QA/QC testboard v2 will improve uniformity of analog input.

Production Test Stand

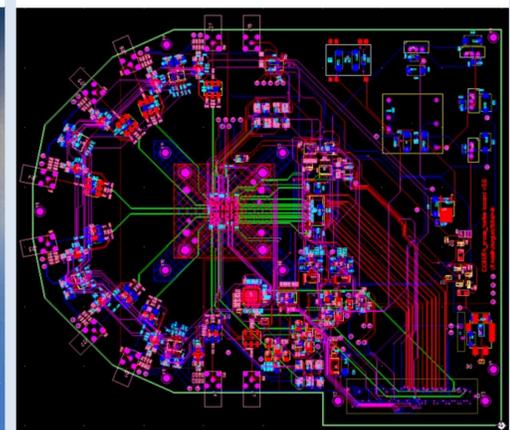
Operational since June 2023 and tested 1000 pre-production chips



QA/QC Testboard v1



Testboard v2 Schematic



QA/QC Tests

1. **Dead-or-alive test:** measure chip health and ability to configure and readout all channels.
 - Quick evaluation of chip performance to discard dead or not functional chips.
 2. **Performance test:** detailed series of analog measurements to evaluate chip performance and assign chip grade.
 - Measure the chip communication, chip power, and analog performance for each of the eight channels.
 - Determine calibration for each channel and evaluate the calibration constants against the ideal constants.
 - Measure calibrated channel baseline mean and width, sine wave performance, and INL/DNL.
- Chip graded into three categories: “meets specs.,” “does not meet specs.,” “not functional”.

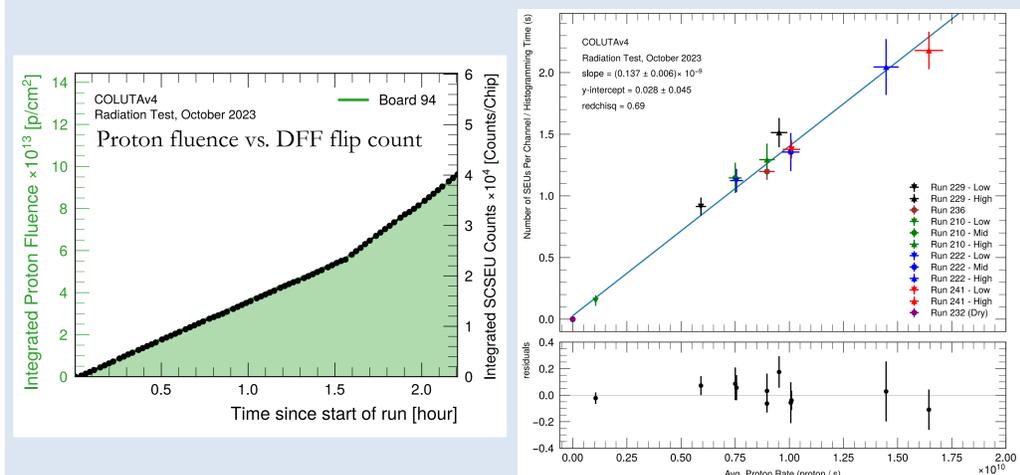
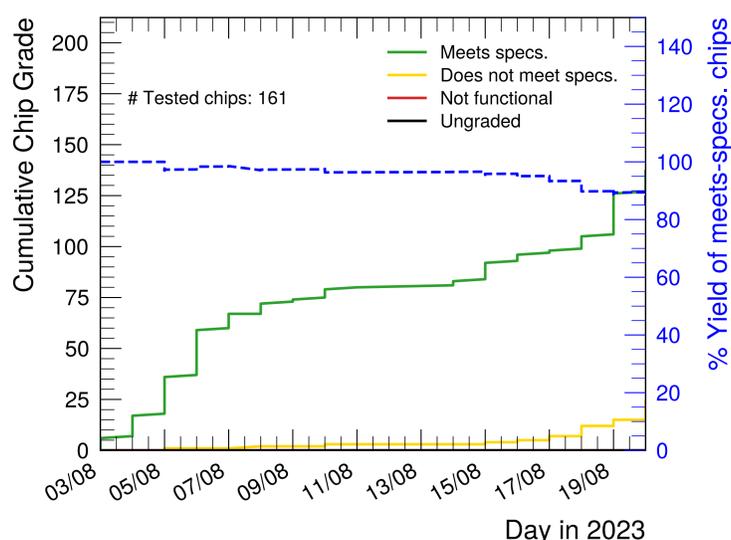
Radiation Testing

- Measured radiation hardness of the pre-production COLUTA chips.
- Irradiated five chips with 226 MeV proton beam at the Massachusetts General Hospital at Boston.
- Monitored the chip health, communication errors, and single-event upsets (SEUs) in the output digital data.
- Each chip was irradiated beyond the required HL-LHC dosage. Exceed radiation tolerance requirement for each chip.
- Observe no latchups or single-event functional interrupts for any chip over the total irradiated dosage.
- Observed number of SEUs proportional to the instantaneous proton dose.
- Count number of instances where the ADC configuration mismatched the expectation. Measure the cross sections of the triple-redundant and single bit flips (DFF).

$$\sigma_{\text{config}} = (2.27 \pm 1.31) \times 10^{-18} \text{ cm}^2/\text{bit} \quad \sigma_{\text{DFF}} = (4.20 \pm 0.03) \times 10^{-10} \text{ cm}^2$$

$$\sigma_{\text{SEU}} = (1.37 \pm 0.07) \times 10^{-10} \text{ cm}^2/\text{channel}$$

Preliminary Testing Yields



References

- [1] ATLAS Collaboration, ATLAS Liquid Argon Calorimeter Phase-I Upgrade Technical Design Report, CERN LHCC-2013-017, ATLAS-TDR-022
- [2] ATLAS Collaboration, The ATLAS experiment at the CERN Large Hadron Collider, JINST 3 (2008) S08003
- [3] ATLAS Collaboration, LAr ADC: Specifications Document for HL-LHC, ATL-COM-LARG-2020-001



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